

SCOPE :

This specification applies to the current type Radial Leaded Inductor
for MCD-1415-SERIES

PRODUCT IDENTIFICATION

MCD- 1415 - 102 K-RU

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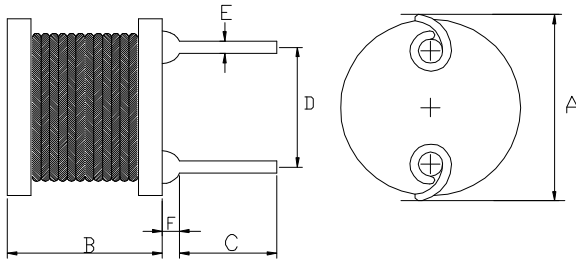
MCDI- Product Code

MCDII- Dimensions Code

MCDIII- Inductance Code

MCDIV- Tolerance Code

(1) SHAPES AND DIMENSIONS



A: 16.5 Max.	mm
B: 15.5 Max.	mm
C: 15.0±2.0	mm
D: 7.5±0.5	mm
E: φ1.0±0.1	mm
F: 3.0 Max.	mm

(2) ELECTRICAL SPECIFICATIONS

SEE TABLE 1

TEST INSTRUMENTS

L : HP 4284A PRECISION LCR METER (or equivalent)

RDC : CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

(3) CHARACTERISTICS

(3)-1 Ambient temperature +60°C Max.

(3)-2 Operate temperature range -40°C ~ +125°C

(Including self temp. rise)

(3)-3 Storage temperature range -40°C ~ +125°C



MAG.LAYERS

TABLE 1

MAGLAYERS PT/NO.	Inductance L(μ H)	Percent Tolerance	Test Frequency	Resistance RDC(Ω)Max.	Rated DC Current	
					IDC1(A)	IDC2(A)
MCD-1415-100□-RU	10	M	100kHz/0.25V	17 m	14.0	6.7
MCD-1415-120□-RU	12	K,M	100kHz/0.25V	19 m	12.0	6.6
MCD-1415-150□-RU	15	K,M	100kHz/0.25V	21 m	10.0	6.5
MCD-1415-220□-RU	22	K,M	100kHz/0.25V	26 m	8.8	5.8
MCD-1415-270□-RU	27	K,M	100kHz/0.25V	28 m	8.3	5.3
MCD-1415-330□-RU	33	K,M	100kHz/0.25V	34 m	7.8	5.2
MCD-1415-390□-RU	39	K,M	100kHz/0.25V	38 m	7.3	5.1
MCD-1415-470□-RU	47	K,M	100kHz/0.25V	46 m	6.7	4.6
MCD-1415-560□-RU	56	K,M	100kHz/0.25V	51 m	6.2	4.5
MCD-1415-680□-RU	68	K,M	100kHz/0.25V	55 m	5.7	4.3
MCD-1415-820□-RU	82	K,M	100kHz/0.25V	58 m	5.2	4.2
MCD-1415-101□-RU	100	K,M	100kHz/0.25V	75 m	4.6	3.4
MCD-1415-121□-RU	120	K,M	100kHz/0.25V	0.100	4.2	3.1
MCD-1415-151□-RU	150	K,M	100kHz/0.25V	0.125	3.7	2.9
MCD-1415-181□-RU	180	K,M	100kHz/0.25V	0.141	3.5	2.7
MCD-1415-221□-RU	220	K,M	100kHz/0.25V	0.208	3.0	2.4
MCD-1415-271□-RU	270	K,M	100kHz/0.25V	0.240	2.7	2.3
MCD-1415-331□-RU	330	K,M	100kHz/0.25V	0.272	2.5	2.1
MCD-1415-391□-RU	390	K,M	100kHz/0.25V	0.303	2.3	2.0
MCD-1415-471□-RU	470	K,M	100kHz/0.25V	0.342	2.1	1.9
MCD-1415-561□-RU	560	K,M	100kHz/0.25V	0.531	1.8	1.6
MCD-1415-681□-RU	680	K,M	100kHz/0.25V	0.590	1.7	1.5
MCD-1415-821□-RU	820	K,M	100kHz/0.25V	0.728	1.5	1.3
MCD-1415-102□-RU	1000	J,K,M	100kHz/0.25V	0.750	1.4	1.2

※ 1. □ specify the inductance tolerance, J(\pm 5%)K(\pm 10%),M(\pm 20%)

※ 2. IDC1 : Based on inductance change (Δ L/L0 : drop10% Max.) @ ambient temp. 25°C

IDC2 : Based on temperature rise (Δ T : 40°C TYP.)

Rated DC Current : The less value which is IDC1 or IDC2.

(4) RELIABILITY TEST METHOD MECHANICAL

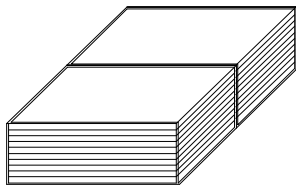
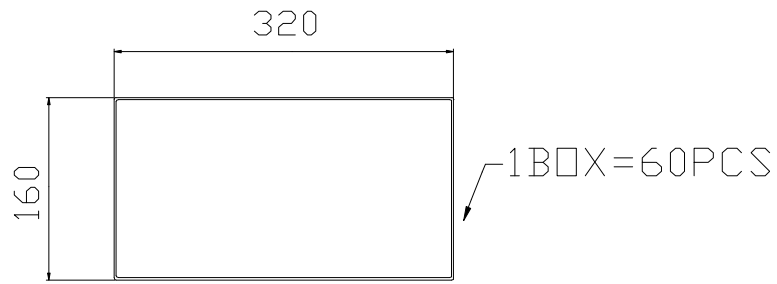
NO.	ITEMS	SPECIFICATIONS	CONDITIONS
1	Solderability test	More than 90% of the terminal electrode should be covered with solder.	Dipping: 245 ± 5 °C, 3 ± 1 seconds
2	lead tensile strength test	1.0 Kg MIN.	The lead of product is pulled with a load of 1.0kg minimum until lead breakdown. The tensile force shall be recorded.
3	Vibration test	$\Delta L/L \leq \pm 7\%$ Visual:OK	The product is fixed into the vibration with amplitude of 1.52m/m at a frequency of 10~55Hz sweeping for 1min. The vibration is done at X,Y, Z direction respectively for 2 houes, totally 6 hours.
4	Soldering heat resistance test	Visual:OK Circuit:OK	The leads of product are dipped into a solder pot of 260±5°C for a duration of 10±1sec. Nothing particular on visual and open circuitry as a result of ore testing.

ENVIRONMENTAL

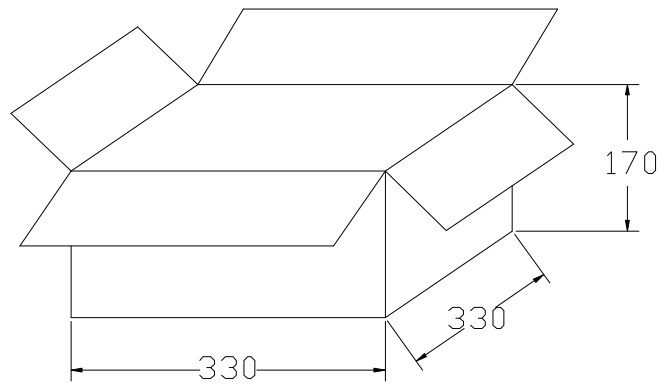
NO.	ITEMS	SPECIFICATIONS	CONDITIONS
1	Humidity endurance test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of 40±2°C, 90~95%RH for 96 hours. Measurement is done after the reaovery of 4~24 hours.
2	High temp endurance test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of 80±2°C, for 72 hours. Measurement is done after recovery of 4~24 hours.
3	Low temp test	$\Delta L/L \leq \pm 5\%$	The product is placed in a chamber of -40±2°C, for 96 hours. Measurement is done after recovery of 4~24 hours.
4	Thermal shock test	$\Delta L/L \leq \pm 5\%$	The specimens are placed in a chamber and the temp is then lowered to -20±2°C for one hour. The temp will raised to +80±2°C for one hour. This constitutes one cycle. Ten cycles of such testing shall be completed. Measurement is made after recovery for 4~24 hours from the completion of testing.



(5) PACKAGE SPECIFICATION (mm)



INNER BOX *14 (840 PCS)



OUT BOX (840 PCS)

